

# TCM1030, TCM1060 DUAL TRANSIENT-VOLTAGE SUPPRESSORS

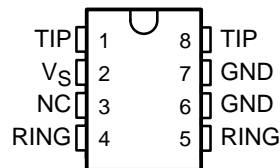
SCTS040 – D3273, JUNE 1989–REVISED DECEMBER 1990

- Meets or Exceeds Bell Standard LSSGR Requirements
- Externally Controlled Negative Firing Voltage . . .  $-70$  V Max
- Wide, Accurately Controlled, Negative Firing Voltage Range . . .  $-5$  V to  $-65$  V
- Surge Current (see Note 1)

	TCM1030	TCM1060
10/1000	16 A	30 A
10/160	25 A	45 A
2/10	35 A	50 A

- High Holding Current  
TCM1030 . . . 100 mA Min  
TCM1060 . . . 150 mA Min

D OR P PACKAGE  
(TOP VIEW)



NC—No internal connection  
The D package is available taped and reeled. Add R suffix (i.e., TCM1030DR).

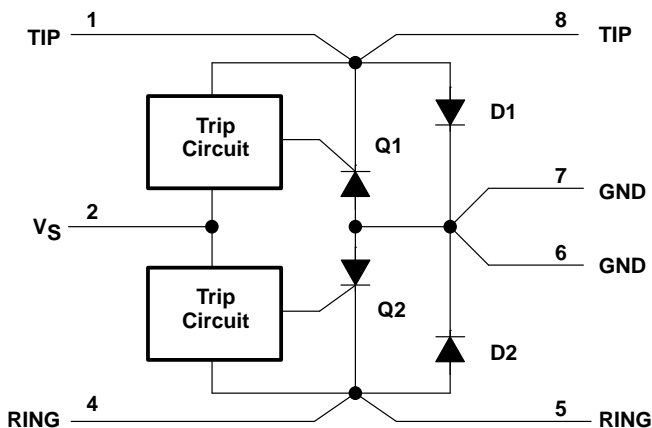
## description

The TCM1030 and TCM1060 dual transient-voltage suppressors are designed specifically for telephone line card protection against lightning and transients induced by ac lines. One of the TIP terminals (pin 1 or 8) and one of the RING terminals (pin 4 or 5) are connected to the tip and ring circuits of a subscriber line interface circuit (SLIC). The battery feed connections between the SLIC and the subscriber line are from the remaining TIP (pin 1 or 8) and RING (pin 4 or 5) through the TCM1030 or the TCM1060 to tip and ring lines. Transients are suppressed between tip and ground and ring and ground.

Positive transients are clamped by diodes D1 and D2. Negative transients that are more negative than  $V_S$  cause the SCR's Q1 and Q2 to crowbar. The high holding current prevents dc latchup as the transient subsides.

The TCM1030 and TCM1060 are characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

## functional block diagram



NOTE 1: The notation 10/1000 refers to a waveshape having  $t_r = 10 \mu\text{s}$  and  $t_w = 1000 \mu\text{s}$  ending at 50% of the peak value. The notation 10/160 is  $t_r = 10 \mu\text{s}$  and  $t_w = 160 \mu\text{s}$ . The notation 2/10 is  $t_r = 2 \mu\text{s}$  and  $t_w = 10 \mu\text{s}$ .

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

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# TCM1030, TCM1060 DUAL TRANSIENT-VOLTAGE SUPPRESSORS

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

TCM1030 nonrepetitive peak surge current (see Note 1):	10/1000	±16 A
	10/160	±25 A
	2/10	±35 A
TCM1060 nonrepetitive peak surge current (see Note 1):	10/1000	±30 A
	10/160	±45 A
	2/10	±50 A
Nonrepetitive peak surge current, $t_W = 10$ ms, half sinewave (see Note 2)		5 A
Continuous 60-Hz sinewave at 1 A		2 s
Continuous total dissipation		See Dissipation Rating Table
Operating free-air temperature range		-40°C to 85°C
Storage temperature range		-40°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or P package		260°C

- NOTES: 1. The notation 10/1000 refers to a waveshape having  $t_r = 10 \mu\text{s}$  and  $t_W = 1000 \mu\text{s}$  ending at 50% of the peak value. The notation 10/160 is  $t_r = 10 \mu\text{s}$  and  $t_W = 160 \mu\text{s}$ . The notation 2/10 is  $t_r = 2 \mu\text{s}$  and  $t_W = 10 \mu\text{s}$ .
2. This value applies when the case temperature is at or below 85°C. The surge current may be repeated after the device has returned to thermal equilibrium.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	OPERATING FACTOR	$T_A = 85^\circ\text{C}$
	POWER RATING	ABOVE $T_A = 25^\circ\text{C}$	POWER RATING
D	725 mW	5.8 mW/°C	377 mW
P	1000 mW	8.0 mW/°C	520 mW

## electrical characteristics over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TCM1030		TCM1060		UNIT	
		MIN	TYP†	MAX	MIN		TYP†
$V_{CF}$ Forward clamping voltage (diode forward voltage) (see Note 3)	$I_{FM} = 1\text{-A}$ transient		1.2	2	1.2	2	V
	$I_{FM} = 10\text{-A}$ transient		2.5	4	2	4	
	$I_{FM} = 16\text{-A}$ transient		4	5	2.5	5	
	$I_{FM} = 30\text{-A}$ transient				3.1	5	
$V_C$ Reverse clamping voltage (SCR on-state voltage) (see Note 3)	$I_{TM} = 1\text{-A}$ transient		1.2	2	1.2	2	V
	$I_{TM} = 10\text{-A}$ transient		2.5	4	2.5	4	
	$I_{TM} = 16\text{-A}$ transient		4	5	3	5	
	$I_{TM} = 30\text{-A}$ transient				4.8	7	
$I_{trip}$ Trip current (see Note 4)	$V_S = -50$ V	-100		-325	-100	-325	mA
$I_H$ Holding current	$V_S = -50$ V	-100			-150		mA
$V_{trip}$ Trip voltage	$V_S = -50$ V, $I = \text{trip current}$	-50		-55	-50	-55	V
	$V_S = -65$ V, $I = \text{trip current}$	-65		-70	-65	-70	
$I_D$ Standby current	TIP and RING at -85 V or GND, $V_S = -85$ V			+5		+5	$\mu\text{A}$
$V_{OS}$ Transient overshoot voltage	$V_S = -50$ V, $t_r = 10$ ns		2.5		2.5		V
	TIP and RING at -50 V		25		25		
$C_{off}$ Off-state capacitance	TIP and RING at GND		50		50		pF
	Critical rate of rise of off-state voltage (see Note 5)	$V_S$ open		-1		-1	
$dv/dt$ voltage (see Note 5)	$V_S = -50$ V		-1		-1		kV/ $\mu\text{s}$

† All typical values are at  $T_A = 25^\circ\text{C}$ .

- NOTES: 3. The current flows through one TIP (or RING) terminal and one of the GND terminals. The voltage is measured between the other TIP (or RING) terminal and the other GND terminal. Measurement time  $\leq 1$  ms.
4. The negative value of trip current refers to the current flowing out of TIP or RING on the line side that is sufficient in magnitude to trigger the SCRs. Measurement time  $\leq 1$  ns.
5. The critical  $dv/dt$  is measured using a linear rate of rise with the maximum voltage limited to -50 V with the  $V_S$  pin connected to the TIP or RING pin being measured.



TYPICAL CHARACTERISTICS

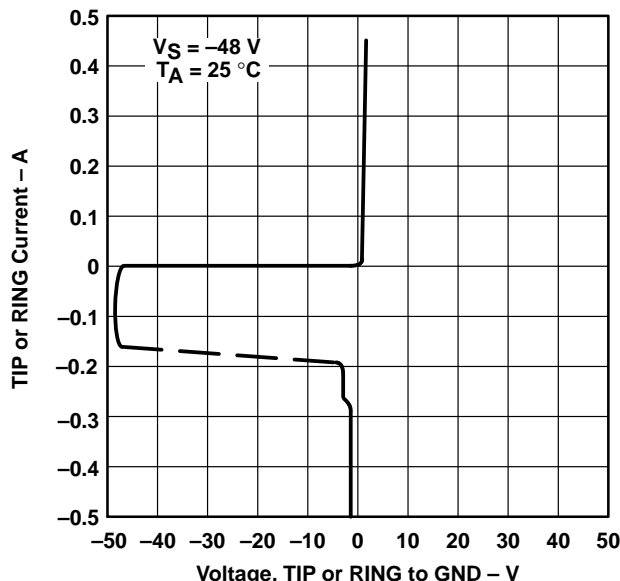


Figure 1. Voltage-Current Characteristics (TIP and RING to GND)

APPLICATION INFORMATION

The trip voltage represents the most negative level of stress applied to the system. Positive transients are clamped by diodes D1 and D2. When a negative transient is applied, current flows from the  $V_S$  input to the TIP or RING terminals where the transient is applied. When the current through TIP or RING reaches the pulse-trip current, the SCR turns on and shorts the TIP or RING terminal to the GND terminal. The majority of the transient energy is dissipated in the external resistor (nominally 100  $\Omega$  and 50  $\Omega$  for TCM1030 and TCM1060, respectively). Current into the  $V_S$  terminal ceases when the SCR turns on. When the energy of the transient has been dissipated so that the current into the TIP or RING terminal due to the transient plus the battery feed supply is less than the holding current, the SCR resets.

If the lead to the  $V_S$  terminal is inductive, it may be necessary to connect a capacitor between  $V_S$  and GND. The capacitor must be placed as close as possible to the  $V_S$  terminal to avoid overshoot in the firing voltage caused by fast rise-time transients.

To avoid dc latchup after the SCR has been fired, the current must be less than the holding current,  $I_H$ . To prevent this from happening, the line feed current must be limited to the following conditions:

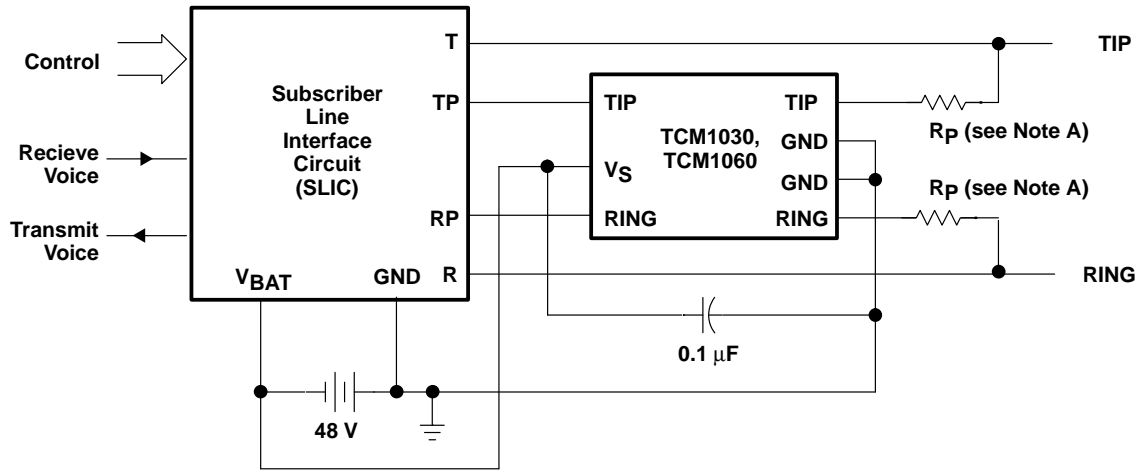
$$\frac{V_{TP} - V_{RP}}{R_{line} + 2R_p} < I_H$$

where  $V_{TP}$  and  $V_{RP}$  are the voltages on the TIP and RING terminals, respectively, of the TCM1030 or TCM1060.

Induced ac currents into TIP or RING (e.g., power-line inductive coupling) must be less than the trip current to prevent the SCR from firing.

Line short circuits to external power sources can damage the suppressor due to excessive power dissipation. Conventional protection techniques, such as fuses or PTC thermistors, should be used to eliminate or reduce the fault current.

APPLICATION INFORMATION



NOTE A: Rp is 100 Ω minimum for TCM1030 and 50 Ω minimum for TCM1060.

Figure 2. Typical Line-Card Application Circuit

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